

Maximum Ratings / Höchstzulässige Werte

Parameter	Condition	Symbol	Datasheet values	Unit
			max.	

Transistor Inverter

Transistor Wechselrichter

Collector-emitter break down voltage Kollektor-Emitter-Sperrspannung		V_{CE}	600	V
DC collector current Kollektor-Dauergleichstrom	$T_j=150^{\circ}\text{C}$ $T_h=80^{\circ}\text{C}$, $T_c=80^{\circ}\text{C}$	I_C	14 19	A
Repetitive peak collector current Periodischer Kollektorspitzenstrom	$t_p=1\text{ms}$ $T_h=80^{\circ}\text{C}$	I_{cpuls}	28	A
Power dissipation per IGBT Verlustleistung pro IGBT	$T_j=150^{\circ}\text{C}$ $T_h=80^{\circ}\text{C}$, $T_c=80^{\circ}\text{C}$	P_{tot}	39 59	W
Gate-emitter peak voltage Gate-Emitter-Spitzenspannung		V_{GE}	± 20	V
SC withstand time Kurzschlußverhalten	$T_j \leq 125^{\circ}\text{C}$ $V_{GE}=15\text{V}$ $V_{CE}=400\text{V}/900\text{V}$	t_{SC}	10 @400V	us

Diode Inverter

Diode Wechselrichter

DC forward current Dauergleichstrom	$T_j=150^{\circ}\text{C}$ $T_h=80^{\circ}\text{C}$, $T_c=80^{\circ}\text{C}$	I_F	16 20-limited by wires	A
Repetitive peak forward current Periodischer Spitzenstrom	$t_p=1\text{ms}$ $T_h=80^{\circ}\text{C}$	I_{FRM}	31	A
Power dissipation per Diode Verlustleistung pro Diode	$T_j=150^{\circ}\text{C}$ $T_h=80^{\circ}\text{C}$, $T_c=80^{\circ}\text{C}$	P_{tot}	22 34	W

Thermal properties

Thermische Eigenschaften

max. Chip temperature max. Chiptemperatur		T_{jmax}	150	$^{\circ}\text{C}$
Storage temperature Lagertemperatur		T_{stg}	-40...+125	$^{\circ}\text{C}$
Operation temperature Betriebstemperatur		T_{op}	-40...+125	$^{\circ}\text{C}$

Insulation properties

Modulisolation

Insulation voltage Isolationsspannung	$t=1\text{min}$	V_{is}	4000	Vdc
Creepage distance Kriechstrecke			min 12,7	mm
Clearance Luftstrecke			min 12,7	mm

flowPACK 0, 600V, 10A

Characteristic values

Description	Symbol	Conditions						Datasheet values			Unit
		T(C°)	Other conditions (Rgon-Rgoff)	VGE(V) VGS(V)	VR(V) VCE(V) VDS(V)	IC(A) IF(A) Id(A)		Min	Typ	Max	

Transistor Inverter, inductive load
Transistor Wechselrichter

Gate emitter threshold voltage Gate-Schwellenspannung	$V_{GE(th)}$	Tj=25°C Tj=125°C	VCE=VGE			0,0004		3	4	5	V
Collector-emitter saturation voltage Kollektor-Emitter Sättigungsspannung	$V_{CE(sat)}$	Tj=25°C Tj=125°C		15		10		1,92 2,15	2,6		V
Collector-emitter cut-off Kollektor-Emitter Reststrom	I_{CES}	Tj=25°C Tj=125°C		0	600				0,06 1,5		mA
Gate-emitter leakage current Gate-Emitter Reststrom	I_{GES}	Tj=25°C Tj=125°C		25	0				200		nA
Integrated Gate resistor Integrierter Gate Widerstand	R_{gint}							-			Ohm
Turn-on delay time Einschaltverzögerungszeit	$t_{d(on)}$	Tj=25°C Tj=125°C	Rgon=48 Ohm Rgoff=24 Ohm	15	300	10			16		ns
Rise time Anstiegszeit	t_r	Tj=25°C Tj=125°C	Rgon=48 Ohm Rgoff=24 Ohm	15	300	10			16		ns
Turn-off delay time Abschaltverzögerungszeit	$t_{d(off)}$	Tj=25°C Tj=125°C	Rgon=48 Ohm Rgoff=24 Ohm	15	300	10			256		ns
Fall time Fallzeit	t_f	Tj=25°C Tj=125°C	Rgon=48 Ohm Rgoff=24 Ohm	15	300	10			37		ns
Turn-on energy loss per pulse Einschaltverlustenergie pro Puls	E_{on}	Tj=25°C Tj=125°C	Rgon=48 Ohm Rgoff=24 Ohm	15	300	10			0,221		mWs
Turn-off energy loss per pulse Abschaltverlustenergie pro Puls	E_{off}	Tj=25°C Tj=125°C	Rgon=48 Ohm Rgoff=24 Ohm	15	300	10			0,248		mWs
Input capacitance Eingangskapazität	C_{ies}	Tj=25°C Tj=125°C	f=1MHz	0	25			0,58	0,7		nF
Output capacitance Ausgangskapazität	C_{oss}	Tj=25°C Tj=125°C	f=1MHz	0	25			0,07	0,08		nF
Reverse transfer capacitance Rückwirkungskapazität	C_{rss}	Tj=25°C Tj=125°C	f=1MHz	0	25			0,05	0,06		nF
Gate charge Gate Ladung	Q_{Gate}	Tj=25°C Tj=125°C		15	480	10		64	83		nC
Thermal resistance chip to heatsink per chip Wärmewiderstand Chip-Kühlkörper pro Chip	R_{thJH}		Thermal grease thickness≤50um Wärmeleitpaste Dicke≤50um $\lambda = 0,61$ W/mK					1,81			K/W
Thermal resistance chip to case per chip Wärmewiderstand Chip-Gehäuse pro Chip	R_{thJC}							1,1946			K/W
Coupled thermal resistance inverter diode-transistor	R_{thJH}		Thermal grease thickness≤50um Wärmeleitpaste Dicke≤50um $\lambda = 0,61$ W/mK					TBD			K/W
Gekoppelte Wärmewiderstand Wechselrichter Diode-Transistor											

Diode Inverter
Diode Wechselrichter

Diode forward voltage Durchlaßspannung	V_F	Tj=25°C Tj=125°C				10		1,59 1,31	2,2		V
Peak reverse recovery current Rückstromspitze	I_{RRM}	Tj=25°C Tj=125°C	Rgon=48 Ohm	15	300	10		20,8			A
Reverse recovery time Sperrverzögerungszeit	t_{rr}	Tj=25°C Tj=125°C	Rgon=48 Ohm	15	300	10		64			ns
Reverse recovered charge Sperrverzögerungsladung	Q_{rr}	Tj=25°C Tj=125°C	Rgon=48 Ohm	15	300	10		0,69			uC
Reverse recovered energy Sperrverzögerungsenergie	E_{rec}	Tj=25°C Tj=125°C	Rgon=48 Ohm	15	300	10		0,106			mWs
Thermal resistance chip to heatsink per chip Wärmewiderstand Chip-Kühlkörper pro Chip	R_{thJH}		Thermal grease thickness≤50um Wärmeleitpaste Dicke≤50um $\lambda = 0,61$ W/mK					3,12			K/W
Thermal resistance chip to case per chip Wärmewiderstand Chip-Gehäuse pro Chip	R_{thJC}							2,0592			K/W
Coupled thermal resistance inverter transistor-diode	R_{thJH}		Thermal grease thickness≤50um Wärmeleitpaste Dicke≤50um $\lambda = 0,61$ W/mK					TBD			K/W
Gekoppelte Wärmewiderstand Wechselrichter Transistor-Diode											

flowPACK 0, 600V, 10A

Characteristic values

Description	Symbol	Conditions					Datasheet values			Unit
		T(°C)	Other conditions (Rgon-Rgoff)	VGE(V) VGS(V)	VR(V) VCE(V) VDS(V)	IC(A) IF(A) Id(A)	Min	Typ	Max	

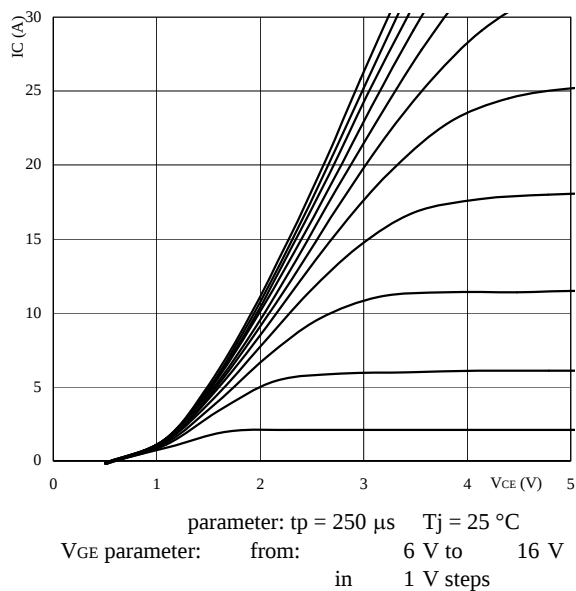
NTC-Thermistor
NTC-Widerstand

Rated resistance Nennwiderstand	R ₂₅	Tj=25°C	Tol. ±5%				20,9	22	23,1	kOhm
Deviation of R100 Abweichung von R100	D _{R/R}	Tc=100°C	R100=1503Ohm					2,9		%/K
Power dissipation given Epcos-Typ Verlustleistung Epcos-Typ angeben	P	Tj=25°C						210		mW
B-value B-Wert	B _(25/100)	Tj=25°C	Tol. ±3%					3980		K

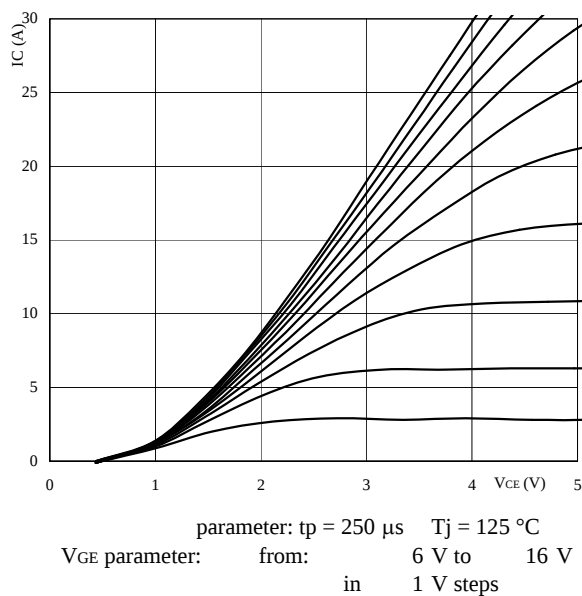
Output inverter

Figure 1. Typical output characteristics
Output inverter IGBT

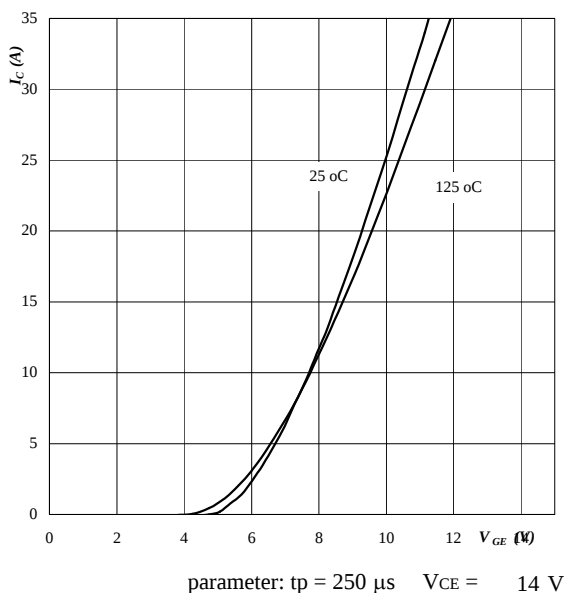
$$I_C = f(V_{CE})$$


Figure 2. Typical output characteristics
Output inverter IGBT

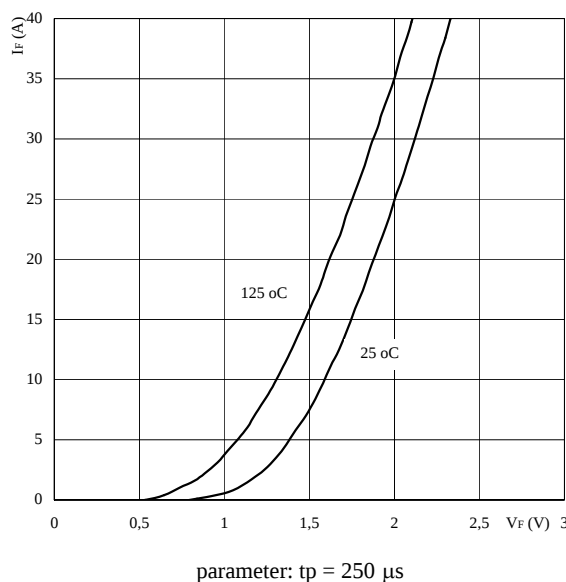
$$I_C = f(V_{CE})$$


Figure 3. Typical transfer characteristics
Output inverter IGBT

$$I_C = f(V_{GE})$$

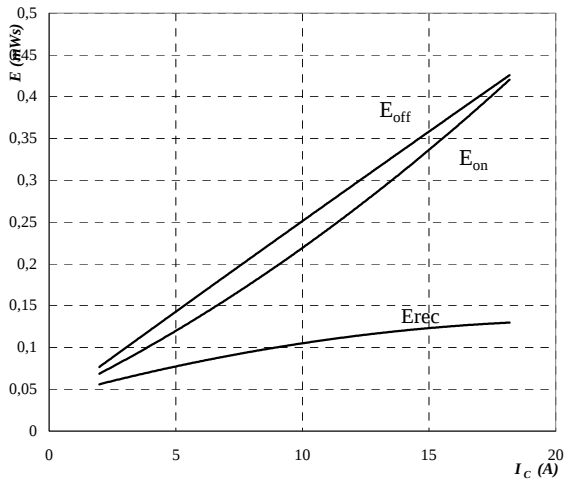

Figure 4. Typical diode forward current as a function of forward voltage
Output inverter FRED

$$I_F = f(V_F)$$



Output inverter

Figure 5. Typical switching energy losses
as a function of collector current
Output inverter IGBT
 $E = f(I_c)$



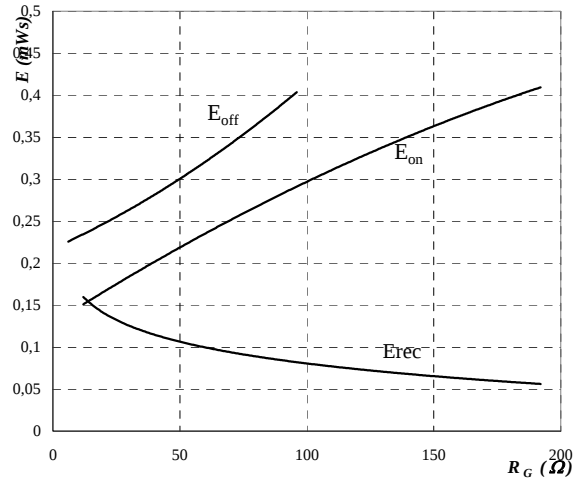
inductive load, $T_j = 125^\circ\text{C}$

$V_{CE} = 300\text{ V}$

$V_{GE} = 15\text{ V}$

$R_{Gon} = 2 \cdot R_{Goff} = 48\ \Omega$

Figure 6. Typical switching energy losses
as a function of gate resistor
Output inverter IGBT
 $E = f(R_G)$



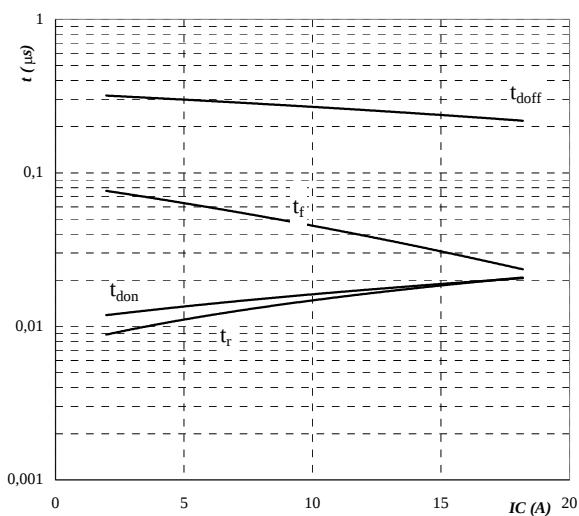
inductive load, $T_j = 125^\circ\text{C}$

$V_{CE} = 300\text{ V}$

$V_{GE} = 15\text{ V}$

$I_c = 10\text{ A}$

Figure 7. Typical switching times as a function of collector current
Output inverter IGBT
 $t = f(I_c)$



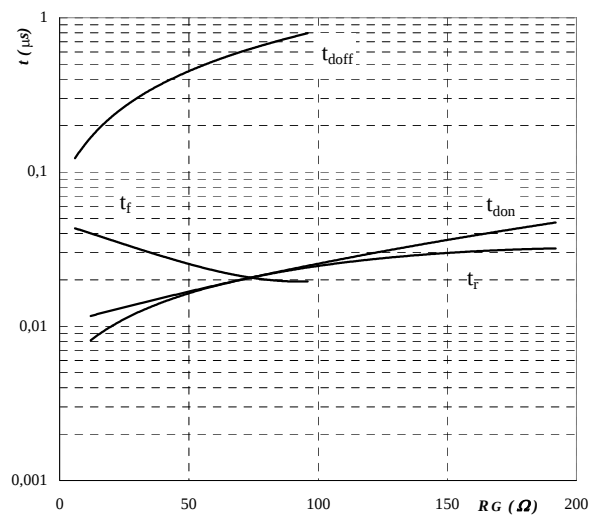
inductive load, $T_j = 125^\circ\text{C}$

$V_{CE} = 300\text{ V}$

$V_{GE} = 15\text{ V}$

$R_{Gon} = 2 \cdot R_{Goff} = 48\ \Omega$

Figure 8. Typical switching times as a function of gate resistor
Output inverter IGBT
 $t = f(R_G)$



inductive load, $T_j = 125^\circ\text{C}$

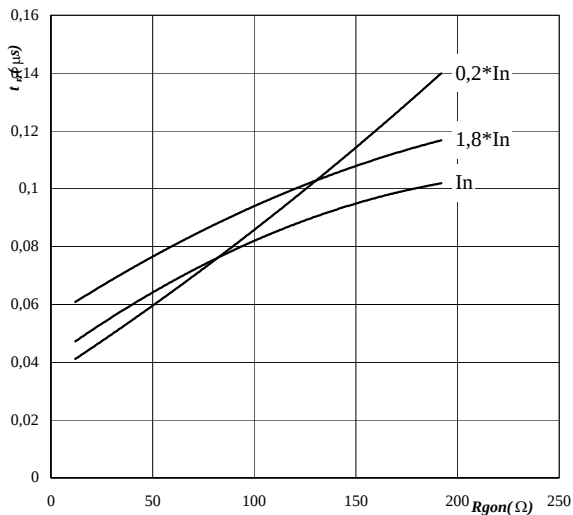
$V_{CE} = 300\text{ V}$

$V_{GE} = 15\text{ V}$

$I_c = 10\text{ A}$

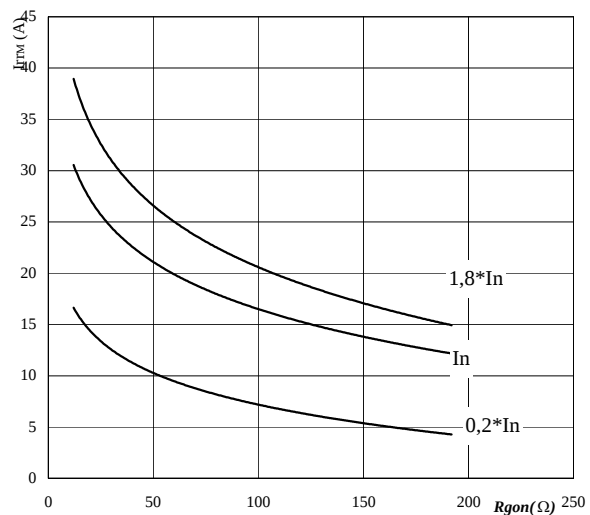
Output inverter

Figure 9. Typical reverse recovery time as a function of gate resistor
Output inverter FRED diode
 $t_{rr} = f(R_{gon})$



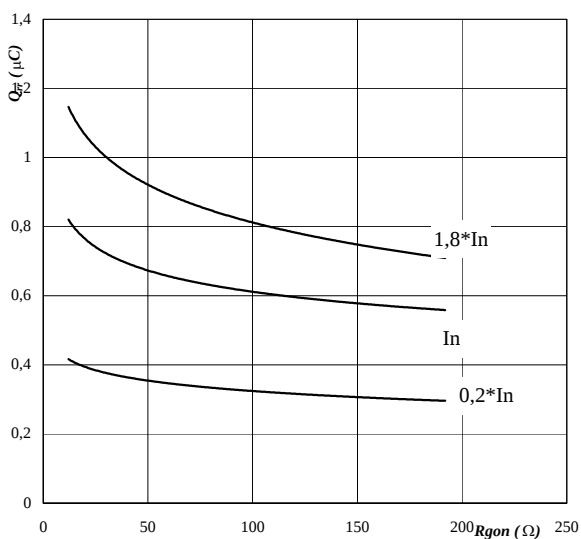
$T_j = 125\text{ }^{\circ}\text{C}$
 $V_R = 300\text{ V}$
 $I_n = 10\text{ A}$

Figure 10. Typical reverse recovery current as a function of gate resistor
Output inverter FRED diode
 $I_{RRM} = f(R_{gon})$



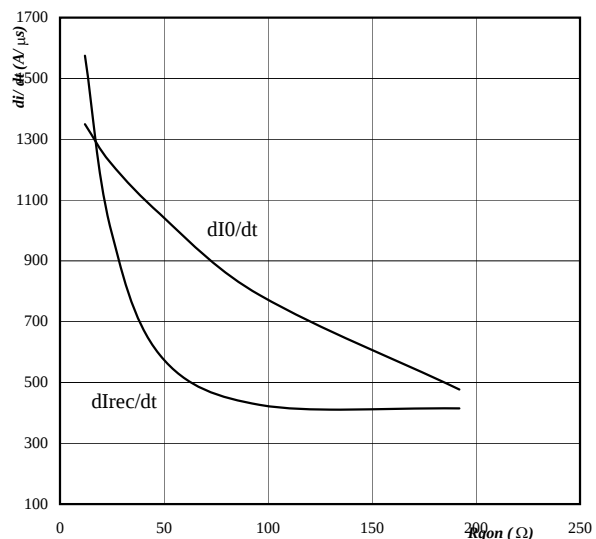
$T_j = 125\text{ }^{\circ}\text{C}$
 $V_R = 300\text{ V}$
 $I_n = 10\text{ A}$

Figure 11. Typical reverse recovery charge as a function of gate resistor
Output inverter FRED diode
 $Q_{rr} = f(R_{gon})$



$T_j = 125\text{ }^{\circ}\text{C}$
 $V_R = 300\text{ V}$
 $I_n = 10\text{ A}$

Figure 12. Typical diode peak rate of fall of forward and reverse recovery current as a function of gate resistor
Output inverter FRED diode
 $di_0/dt, dI_{rec}/dt = f(R_{gon})$



$T_j = 125\text{ }^{\circ}\text{C}$
 $V_R = 300\text{ V}$
 $I_F = 10\text{ A}$

Output inverter

Figure 13. IGBT transient thermal impedance
as a function of pulse width

$$Z_{thJH} = f(t_p)$$

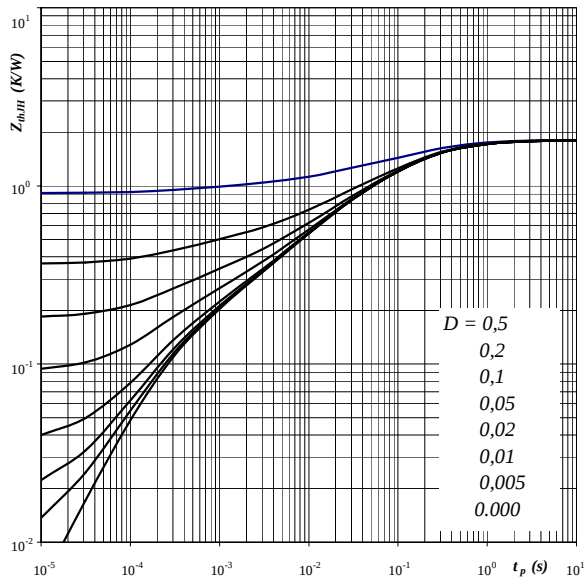
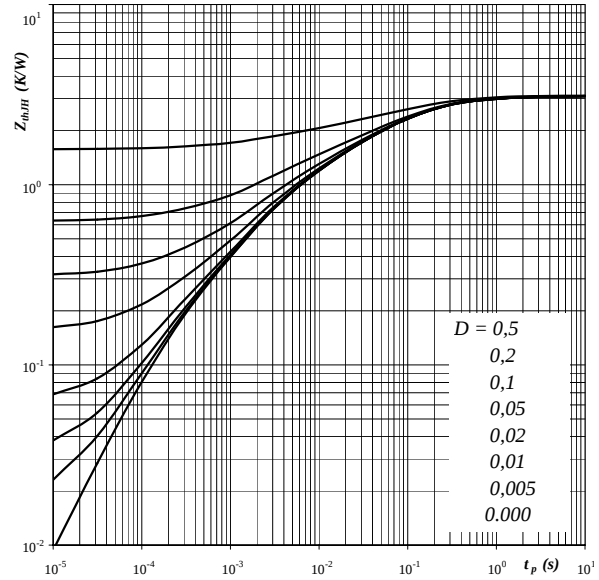

Parameter: $D = t_p / T$
 $R_{thJH} \quad 1,81 \text{ K/W}$

Figure 14. FRED transient thermal impedance
as a function of pulse width

$$Z_{thJH} = f(t_p)$$


Parameter: $D = t_p / T$
 $R_{thJH} \quad 3,12 \text{ K/W}$

IGBT thermal model values

R (C/W)	Tau (s)
0,04	2,2E+01
0,20	9,3E-01
0,68	1,7E-01
0,40	4,0E-02
0,31	8,9E-03

FRED thermal model values

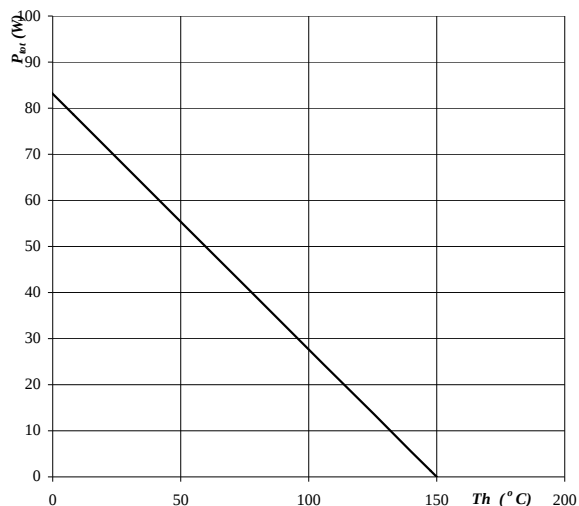
R (C/W)	Tau (s)
0,05	6,3E+01
0,19	1,4E+00
0,90	1,8E-01
0,86	4,3E-02
0,66	7,5E-03

Output inverter

Figure 15. Power dissipation as a function of heatsink temperature

Output inverter IGBT

$$P_{tot} = f(T_h)$$

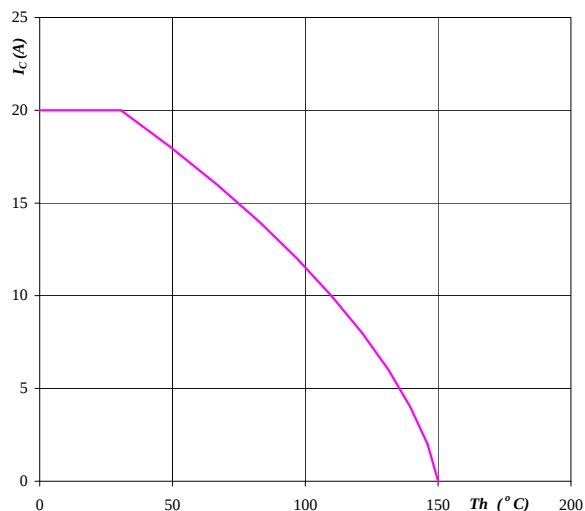


parameter: $T_j = 150^\circ\text{C}$

Figure 16. Collector current as a function of heatsink temperature

Output inverter IGBT

$$I_c = f(T_h)$$



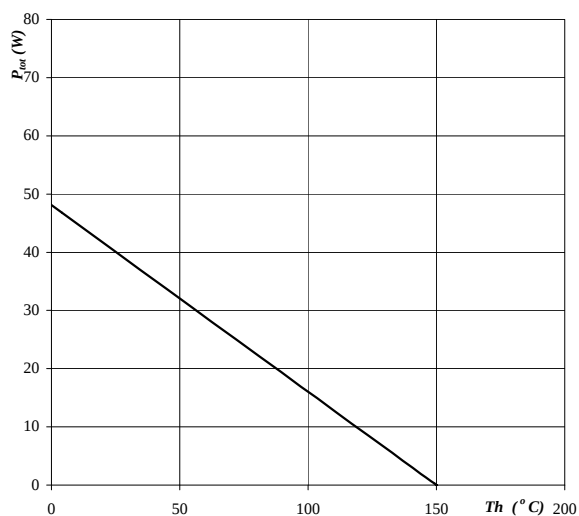
parameter: $T_j = 150^\circ\text{C}$

$V_{GE} = 15\text{ V}$

Figure 17. Power dissipation as a function of heatsink temperature

Output inverter FRED

$$P_{tot} = f(T_h)$$

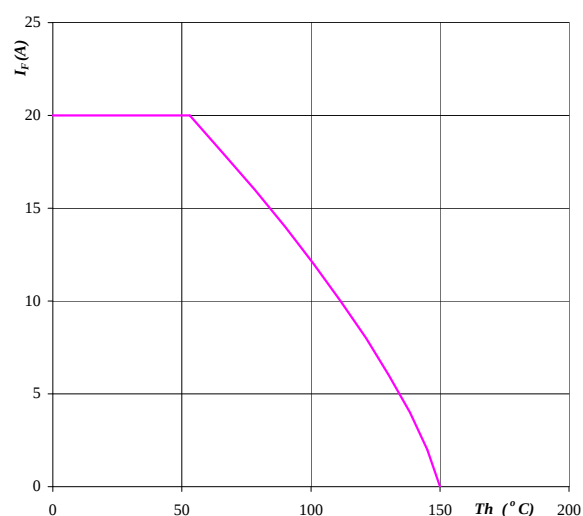


parameter: $T_j = 150^\circ\text{C}$

Figure 18. Forward current as a function of heatsink temperature

Output inverter FRED

$$I_F = f(T_h)$$



parameter: $T_j = 150^\circ\text{C}$

Thermistor

**Figure 23. Typical NTC characteristic
as a function of temperature**

NTC

$$R_T = f(T)$$

